Toshiba Discrete Products (Small-signal Devices): Announcement about Change of Production Site for Domestic Products



October 9, 2019 H440-9J-008P-E •Discrete Semiconductor Quality & Reliability Engineering Department •Quality Assurance Department, Himeji Operations – Semiconductor **Discrete Semiconductor Division Toshiba Electronic Devices & Storage Corporation**

•Quality Assurance Department Kaga Toshiba Electronics Corporation

Abbreviation list

Kaga:	Kaga Toshiba Electronics Corporation
Nogata:	Nogata Operations Buzen Toshiba Electronics Corporation
Himehan:	Himeji Operations – Semiconductor Toshiba Electronic Devices & Storage Corporation

1. Background of our proposal for production site change

We wish to express our sincerest appreciation for your continued patronage to our semiconductors.

We are now shifting the production of our discrete semiconductors (small-signal devices) to an overseas assembly site, the Thailand factory, where the setup of the latest facilities was completed after the flooding in 2011. The new factory has prepared a broad lineup of packages, established a supply system of the products for consumer use and automotive use, and started supplying them. (The Thailand factory has been proactively promoting 100% halogen-free products, 100% Pb-free outer plating, and Cu wire use so as to improve productivity, enhance competitiveness in price, and address environmental needs.)

Since new products are basically to be manufactured in overseas sites, the production scale in Japan will be reducing. Against this backdrop, with a view to maintaining production, ensuring a steady supply, and improving productivity, we are proposing a change of domestic production site.

[Change of production site]

Our main packages, which are currently manufactured at Kaga and Nogata, will be produced at Nogata only. Positioning Nogata as the largest assembly factory of smallsignal devices in Japan, we will seek to enhance the supply system. Furthermore, we will prevent productivity decline which could be caused by decentralized production sites and maintain a steady supply.

* There are already some products whose specifications show both Kaga and Nogata as production sites.

3. Packages subjected to the change

The change will apply to packages of US6, S-Mini (products with frame of 42 alloy), SMV, SM6, and SMQ.

Schedule: The change will start from April 2020.

See the attachment for the list of product types (US6, S-Mini (products with frame of 42 alloy), SMV, SM6, and SMQ).

Differences before and after the change

Changes in 5M1E

Changes resulting from the change from Kaga to Nogata products are shown below.

5M1E	Change point						
Man	To be changed (Operator who has received equivalent training)						
Machine	To be changed (Machine of the same model, change of site (place))						
Measurement	No change (Measuring instrument with the same functions)						
Method	No change						
Material	No change						
Environment	To be changed (Production line which has been used for manufacturing other semiconductors)						

Both Kaga and Nogata have a proven track record of production.

Himehan handles quality services and serves as a contact to cope with complaints and quality issues for Nogata products. The change of production site will not affect the product quality including electrical characteristics and reliability.

1) Change in operator

Nogata operators are educated as follows. Based on the operator qualification system, educated operators are engaged in operations.

《Operator qualification flow》



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《Operator's skill level》

Rank	Skill level	Criteria
A	 Able to maintain equipment including processing parts Understands the safety control and able to correct failure points Able to switch the package 	The skill level is determined according to the results of paper test and skill test.
В	 Able to adjust a machine with trouble Able to take action against quality abnormalities Able to regularly check machines 	* The chief foreman makes judgment based on the skill, experience and work performance of
С	 Able to run and daily check equipment Able to judge pass/fail of products 	the operator.
D	- Has finished the introductory education (Under OJT)	

«Educational material»

Education is provided by using

- Operational procedures (check sheets), machine manuals
- Inspection criteria, abnormality handling standards, past failures, etc.

2) Education on quality and automotive products

Education on automotive products, as well as quality, is provided to the staff and operators. Details of education for Nogata operators are shown below.



Education on automotive products is provided to the managements/staff/operators to raise awareness of the importance of the quality of automotive products. They are educated periodically (once a year) as well as when they are appointed to a new work place.

3) Nogata's profile

The company profile of Nogata is shown below. Himehan is in charge of the quality.



Number of employees: About 450

Products: Opto devices

Production scale: About 120 million pieces/month







Location: 1891-1 Kamishinnyuu, Nogata-shi, Fukuoka

Site area: 13,303 m⁴ Number of employees: About 110 Products: Small-signal devices, power devices Production scale: About 280 million pieces/month

4) Work environment

The following table shows the environment of operation line's processing points and general rooms. The environmental standards have been established by each factory based on Toshiba's common guidelines. There are no significant differences before and after the change.

	Processin	g point	General room (Testing room)						
	Kaga Nogata		Kaga	Nogata					
Standard for dust control (Count of particles of 0.5µm or more)	1,000/cf or less	1,000/cf or less	100,000/cf or less	100,000/cf or less					
Standard for ESD control	ESD is controlled und less). (Items including EBP signs, chairs, etc	ESD is controlled under Toshiba's common standards (Specification: ±100V or less). (Items including wrist straps, antistatic shoes, antistatic mats, SUS chains, EBP signs, chairs, etc. are also defined and controlled.)							
Standard for temperature/humidity control	20∼30℃ 20∼70%RH	20∼30°C 20∼70%RH	20∼30°C 20∼70%RH	20∼30℃ 20∼70%RH					

5) Dust, ESD, temperature, and humidity

Averages of actual values of dust, ESD, temperature, and humidity are shown below. There are no major changes before and after the transfer.

	General room (Testing room)							
	Кас	ja	Nogata					
Result of dust count (Count of particles of 0.5µm or more)	5820)/cf	5745/cf					
ESD	5\	/	4	·V				
Temperature and humidity	25° C	50%RH	24°C	48%RH				

Control item

Control plan (QC process flow)

The same control plan has been applied to Kaga and Nogata. There are no differences before and after the change.

Manufacture	e Production	Items Controlled/Inspected	Check Frequency
Flow Chart	Process	· · · · ·	. ,
	(Chip) (Frame) Die Bonding	Temperature	Once / Day
	(Bonding Wire) Wire Bonding	Temperature, Bonding Strength	Once / Day Once / Week
	Appearance Inspection	Bonding Status	Once / 2h
	(Molding Resin) Molding	Temperature	Once / Week
0	Removing Burr		
↓	Solder Plating	Plating Thickness	Once / Day
	Lead Cutting & Bending		
	Testing	Electrical Characteristics	
0	Marking		
	Appearance Inspection		
	(Taping Material) Taping		
	(Packing Material) Packing		
	Quality Monitoring	Electrical Characteristics Reliability Test	
\checkmark	Shipping		
Symbol	▽:Storage ○:Operative ☑∆:Special check ○-□ :(ation ∏:100%Test ⊠ Check	1: Sampling inspection

1) Selection of representative products

Representative products were picked out for evaluation.

In order to evaluate the package, a product that has the largest chip and a product that has the highest withstand voltage were selected as representatives.

Package	Representative product	Criteria for selection
US6	HN2D02FU SSM6J08FU	Product with the highest withstand voltage Product with the largest chip



2) Comparison in wire bonding (Representative product: SSM6J08FU (US6))

The pull strength of bonding wire and the width of deformed bonding ball were checked. No differences were found in process capability and no problems were found.

 $(n=10 \text{ pcs} \times 3 \text{ lots})$

Proces	S	Wire bonding				
Important control item		Pull strength	Deformed ball width			
Calc	Kaga	2.15	1.75			
Срк	Nogata	2.27	1.92			

3) Comparison in product dimensions (Representative product: SSM6J08FU (US6))

Product dimensions were measured. No differences were found in process capability and no problems were found. (n=10 pcs×3 lots)

Produc- tion site	ltem	A (mm)	B (mm)	C (mm)	D (mm)	E (mm)	F (mm)	G (mm)	H (mm)	l (mm)	J (mm)
	Avg	2.119	1.250	1.978	1.293	0.644	0.650	0.215	0.942	0.048	0.120
Kaga	Ср	2.33	6.72	5.89	3.64	-	-	8.88	4.08	1.79	4.47
	Cpk	1.88	6.72	5.25	3.40	-	-	7.75	2.34	1.73	1.79
	Avg	2.096	1.248	1.969	1.301	0.662	0.639	0.226	0.938	0.064	0.112
Nogata	Ср	5.64	7.20	13.74	5.49	_	-	4.98	4.49	2.53	7.13
	Cpk	5.46	7.07	11.64	5.39	-	-	4.86	2.74	1.82	1.76
Specific	ation	2.0~2.2	1.15~1.35	1.8~2.2	1.2~1.4	0.65typ	0.65typ	0.15~0.3	0.8~1.0	0~0.1	0.10~0.20
Judgm	ient	ОК									



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* Specification with upper and lower limits: Cpk, Cp, Average * Specification with either limit: Cp, Average

* Typ. value: Average

4) Comparison in initial characteristics (Representative product: SSM6J08FU (US6))

Initial characteristics (electrical characteristics) were measured. The measurements fell within the specifications. No differences were found in the results and no problems were found.



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								(11-10	$pc_{3} \sim 10(3)$	1a-25 C
ltom	Sumbol	Test conditions	Specification (TD)			Kaga p	roduct	Nogata product		
nem	Symbol	Test conditions	Min	Тур	Max	Unit	Average	Cpk	Average	Cpk
Forward transfer admittance	Yfs	VDS=-3V ID=-0.65A	1.3	2.7	-	S	2.690	24.58	2.674	39.5
Drain-Source ON resistance	RDS (ON1)	ID=-0.65A VGS=-4V	-	140	180	mΩ	135.3	6.54	141.7	7.96
k	Kaga	Ν	logata			Kag	а	Nog	ata	
	Yfs		Yfs			R	DS(ON1)	RE	DS(ON1)	
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								(0 0 00 0 10 00)	
Itam Sumbol		Test conditions	Specification (TD)		Kaga product		Nogata product			
nem	Symbol	Test conditions	Min	Тур	Max	Unit	Average	Cpk	Average	Cpk
Drain-Source ON resistance	RDS (ON2)	ID=-0.65A VGS=-2.5V	-	200	260	mΩ	186.2	10.17	193.1	11.27
Drain-Source ON resistance	RDS (ON3)	ID=-0.65A VGS=-2.0V	-	260	460	mΩ	248.4	26.28	258.0	25.45
k	(aga	N	logata			Kag	a	Nog	ata	
	RDS(ON	12)	RDS(O	N2)		RI	DS(ON3)	KL	JS(UN3)	
30	⁵⁰ F	30	^{oo} F			⁵⁰⁰ F		⁵⁰⁰ [
			Ē	[450	460mQ 450		460mΩ \	ļ,
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(n=10 pcs×3 lots) Ta=25°C

5) Comparison in product appearance (Representative product: SSM6J08FU (US6))



No problems were found in product appearance.

[Item checked: Mark legibility, mark specifications, broken letters, surface of molding resin]

6) Comparison in product by X-ray (Representative product: SSM6J08FU (US6))

	Kaga	Nogata
Overall view		
Shape of wire loop	Jun -	5000

Products were x-rayed. No problems were found. [Item checked: Wire sweep, wire shape]

7) Analysis on conforming products (Representative product: SSM6J08FU (US6))



Conforming products were analyzed. No problems were found. [Item checked: Bonding position, state of wire-to-chip joint]

8) Reliability evaluation (Representative product: SSM6J08FU (US6))

Reliability was evaluated. No problems were found.

No.	Test item	Test conditions	Sample size (pcs)	Test time	Number of defectives
1	Pressure cooker test	121°C/203kPa (100%), unsaturated	n=10 pcs×3 lots	24 hours	0/30 pcs
2	Temperature cycling test	-65°C (30 min)∼150°C (30 min)	n=10 pcs×3 lots	100 cycles	0/30 pcs

Samples were pretreated for the tests.

The test conditions are based on the standards (JEITA)EIAJ ED-4701. The judgment was made in accordance with the electrical characteristics specifications of the technical data.

9) Check on correlation between testers (Representative product: SSM6J08FU (US6)) The correlation between testers of both production sites was checked. Neither differences nor problems were found.





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Our Semiconductor and Storage products will always be a driving force to change the world

Toshiba Electronic Devices and Storage, together with our customers, will accelerate our future journey. We aim to be a company that will be chosen for our pioneering technology and spirit embedded in our products.